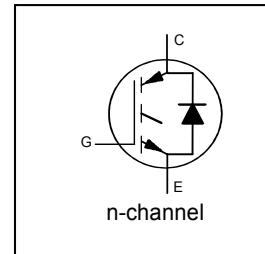


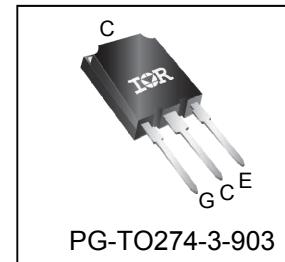
INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE

Features

- Low $V_{CE(on)}$ Trench IGBT Technology
- Low Switching Losses
- 6 μ s SCSOA
- Square RBSOA
- 100% of the parts tested for I_{LM} ^①
- Positive $V_{CE(on)}$ Temperature Coefficient
- Soft Recovery Co-pak Diode
- Lead-Free, RoHS Compliant
- Automotive Qualified *



$V_{CES} = 600V$
 $I_C = 160A, T_C = 100^\circ C$
 $t_{SC} \geq 6\mu s, T_{J(MAX)} = 175^\circ C$
 $V_{CE(on)\ typ.} = 1.70V$



| | | |
|------|-----------|---------|
| G | C | E |
| Gate | Collector | Emitter |

Benefits

- High Efficiency in a Wide Range of Applications
- Suitable for Applications in the Low to Mid-Range Frequencies
- Rugged Transient Performance for Increased Reliability
- Excellent Current Sharing in Parallel Operation
- Low EMI

| Base Part Number | Package Type | Standard Pack | | Orderable Part Number |
|------------------|----------------|---------------|----------|-----------------------|
| | | Form | Quantity | |
| AUIRGPS4070D0 | PG-T0274-3-903 | Tube | 25 | AUIRGPS4070D0 |

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

| | Parameter | Max. | Units |
|---------------------------|---|-----------------------------------|-------|
| V_{CES} | Collector-to-Emitter Voltage | 600 | V |
| $I_C @ T_C = 25^\circ C$ | Continuous Collector Current | 240 ^⑤ | |
| $I_C @ T_C = 100^\circ C$ | Continuous Collector Current | 160 | |
| $I_{NOMINAL}$ | Nominal Current | 120 | |
| I_{CM} | Pulse Collector Current, $V_{GE} = 15V$ | 360 | |
| I_{ILM} | Clamped Inductive Load Current, $V_{GE} = 20V$ ^① | 480 | |
| $I_{F NOMINAL}$ | Diode Nominal Current ^② | 120 ^⑤ | |
| I_{FM} | Diode Maximum Forward Current ^② | 480 | |
| V_{GE} | Continuous Gate-to-Emitter Voltage | ± 20 | V |
| | Transient Gate-to-Emitter Voltage | ± 30 | |
| $P_D @ T_C = 25^\circ C$ | Maximum Power Dissipation | 750 | W |
| $P_D @ T_C = 100^\circ C$ | Maximum Power Dissipation | 375 | |
| T_J | Operating Junction and | -55 to +175 | °C |
| T_{STG} | Storage Temperature Range | | |
| | Soldering Temperature, for 10 sec. | 300 (0.063 in. (1.6mm) from case) | |

Thermal Resistance

| | Parameter | Typ. | Max. | Units |
|-------------------|--|------|------|-------|
| R_{QJC} (IGBT) | Thermal Resistance Junction-to-Case (each IGBT) ^④ | — | 0.20 | °C/W |
| R_{QJC} (Diode) | Thermal Resistance Junction-to-Case (each Diode) ^④ | — | 0.45 | |
| R_{QCS} | Thermal Resistance, Case-to-Sink (flat, greased surface) | 0.24 | — | |
| R_{QJA} | Thermal Resistance, Junction-to-Ambient (typical socket mount) | — | 40 | |

* Qualification standards can be found at www.infineon.com

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---|---|------|------|-----------|----------------------|---|
| $V_{(\text{BR})\text{CES}}$ | Collector-to-Emitter Breakdown Voltage | 600 | — | — | V | $V_{\text{GE}} = 0\text{V}$, $I_C = 500\mu\text{A}$ ③ |
| $\Delta V_{(\text{BR})\text{CES}}/\Delta T_J$ | Temperature Coeff. of Breakdown Voltage | — | 0.74 | — | V/ $^\circ\text{C}$ | $V_{\text{GE}} = 0\text{V}$, $I_C = 5\text{mA}$ (25°C - 175°C) |
| $V_{\text{CE}(\text{on})}$ | Collector-to-Emitter Saturation Voltage | — | 1.7 | 2.0 | V | $I_C = 120\text{A}$, $V_{\text{GE}} = 15\text{V}$, $T_J = 25^\circ\text{C}$ |
| | | — | 2.0 | — | | $I_C = 120\text{A}$, $V_{\text{GE}} = 15\text{V}$, $T_J = 150^\circ\text{C}$ |
| | | — | 2.1 | — | | $I_C = 120\text{A}$, $V_{\text{GE}} = 15\text{V}$, $T_J = 175^\circ\text{C}$ |
| $V_{\text{GE}(\text{th})}$ | Gate Threshold Voltage | 4.0 | — | 6.5 | V | $V_{\text{CE}} = V_{\text{GE}}$, $I_C = 5.6\text{mA}$ |
| $\Delta V_{\text{GE}(\text{th})}/\Delta T_J$ | Threshold Voltage temp. coefficient | — | -16 | — | mV/ $^\circ\text{C}$ | $V_{\text{CE}} = V_{\text{GE}}$, $I_C = 5.6\text{mA}$ (25°C - 175°C) |
| g_{fe} | Forward Transconductance | — | 87 | — | S | $V_{\text{CE}} = 50\text{V}$, $I_C = 120\text{A}$ |
| I_{CES} | Collector-to-Emitter Leakage Current | — | 1.0 | 200 | μA | $V_{\text{GE}} = 0\text{V}$, $V_{\text{CE}} = 600\text{V}$ |
| | | — | 2.0 | — | mA | $V_{\text{GE}} = 0\text{V}$, $V_{\text{CE}} = 600\text{V}$, $T_J = 175^\circ\text{C}$ |
| V_{FM} | Diode Forward Voltage Drop | — | 1.8 | 2.1 | V | $I_F = 120\text{A}$ |
| | | — | 1.9 | — | | $I_F = 120\text{A}$, $T_J = 175^\circ\text{C}$ |
| I_{GES} | Gate-to-Emitter Leakage Current | — | — | ± 100 | nA | $V_{\text{GE}} = \pm 20\text{V}$ |

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---------------------|--------------------------------------|-------------|------|------|---------------|---|
| Q_g | Total Gate Charge (turn-on) | — | 250 | 375 | nC | $I_C = 120\text{A}$ |
| Q_{ge} | Gate-to-Emitter Charge (turn-on) | — | 65 | 98 | | $V_{\text{GE}} = 15\text{V}$ |
| Q_{gc} | Gate-to-Collector Charge (turn-on) | — | 100 | 150 | | $V_{\text{CC}} = 400\text{V}$ |
| E_{on} | Turn-On Switching Loss | — | 5.7 | 6.7 | mJ | |
| E_{off} | Turn-Off Switching Loss | — | 4.2 | 5.2 | | |
| E_{total} | Total Switching Loss | — | 9.9 | 11.9 | | $I_C = 120\text{A}$, $V_{\text{CC}} = 400\text{V}$, $V_{\text{GE}} = 15\text{V}$ |
| $t_{d(\text{on})}$ | Turn-On delay time | — | 40 | 60 | | $R_G = 4.7\Omega$, $L = 87\mu\text{H}$, $T_J = 25^\circ\text{C}$ |
| t_r | Rise time | — | 125 | 155 | ns | Energy losses include tail & diode reverse recovery |
| $t_{d(\text{off})}$ | Turn-Off delay time | — | 140 | 170 | | |
| t_f | Fall time | — | 120 | 170 | | |
| E_{on} | Turn-On Switching Loss | — | 6.4 | — | | |
| E_{off} | Turn-Off Switching Loss | — | 4.7 | — | mJ | |
| E_{total} | Total Switching Loss | — | 11.1 | — | | $I_C = 120\text{A}$, $V_{\text{CC}} = 400\text{V}$, $V_{\text{GE}} = 15\text{V}$ |
| $t_{d(\text{on})}$ | Turn-On delay time | — | 40 | — | | $R_G = 4.7\Omega$, $L = 87\mu\text{H}$, $T_J = 175^\circ\text{C}$ |
| t_r | Rise time | — | 110 | — | ns | Energy losses include tail & diode reverse recovery |
| $t_{d(\text{off})}$ | Turn-Off delay time | — | 160 | — | | |
| t_f | Fall time | — | 125 | — | | |
| C_{ies} | Input Capacitance | — | 7600 | — | pF | $V_{\text{GE}} = 0\text{V}$ |
| C_{oes} | Output Capacitance | — | 510 | — | | $V_{\text{CC}} = 30\text{V}$ |
| C_{res} | Reverse Transfer Capacitance | — | 230 | — | | $f = 1.0\text{Mhz}$ |
| RBSOA | Reverse Bias Safe Operating Area | FULL SQUARE | | | | $T_J = 175^\circ\text{C}$, $I_C = 480\text{A}$ $V_{\text{CC}} = 480\text{V}$, $V_p \leq 600\text{V}$ $R_g = 4.7\Omega$, $V_{\text{GE}} = +20\text{V}$ to 0V |
| SCSOA | Short Circuit Safe Operating Area | 6 | — | — | μs | $V_{\text{CC}} = 400\text{V}$, $V_p \leq 600\text{V}$ $R_g = 5.0\Omega$, $V_{\text{GE}} = +15\text{V}$ to 0V |
| E_{rec} | Reverse Recovery Energy of the Diode | — | 1740 | — | μJ | $T_J = 175^\circ\text{C}$ |
| t_{rr} | Diode Reverse Recovery Time | — | 210 | — | ns | $V_{\text{CC}} = 400\text{V}$, $I_F = 120\text{A}$ |
| I_{rr} | Peak Reverse Recovery Current | — | 45 | — | A | $V_{\text{GE}} = 15\text{V}$, $R_g = 4.7\Omega$, $L = 87\mu\text{H}$ |

Notes:

- ① $V_{\text{CC}} = 80\%$ (V_{CES}), $V_{\text{GE}} = 20\text{V}$, $L = 3.5\mu\text{H}$, $R_g = 47\Omega$ tested in production ILM $\leq 400\text{A}$.
- ② Pulse width limited by max. junction temperature.
- ③ Refer to AN-1086 for guidelines for measuring $V_{(\text{BR})\text{CES}}$ safely.
- ④ R_θ is measured at T_J approximately 90°C .
- ⑤ Calculated continuous current based on maximum allowable junction temperature. Package IGBT current limit is 195A. Package diode current limit is 120A. Note that current limitations arising from heating of the device leads may occur.

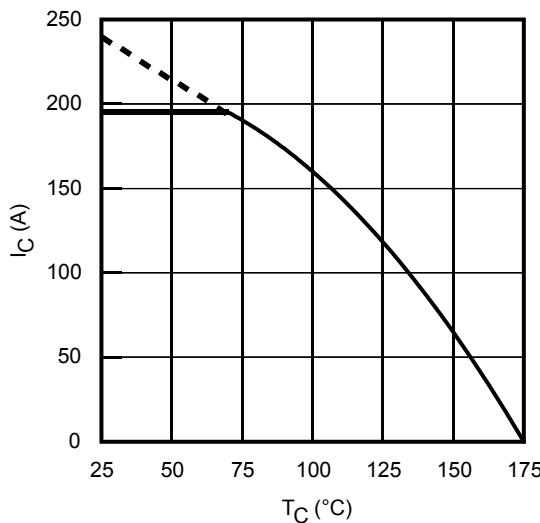


Fig. 1 - Maximum DC Collector Current vs. Case Temperature

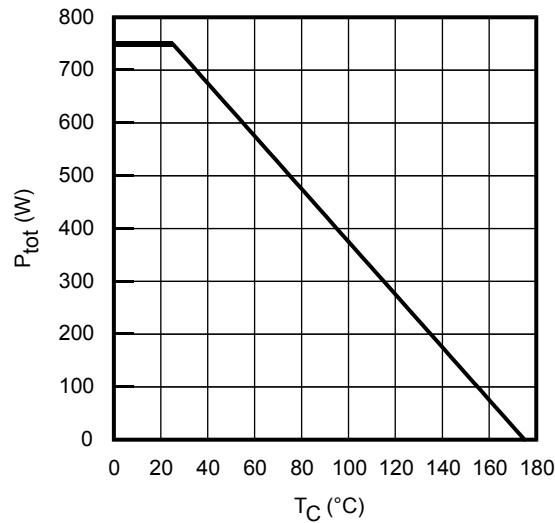


Fig. 2 - Power Dissipation vs. Case Temperature

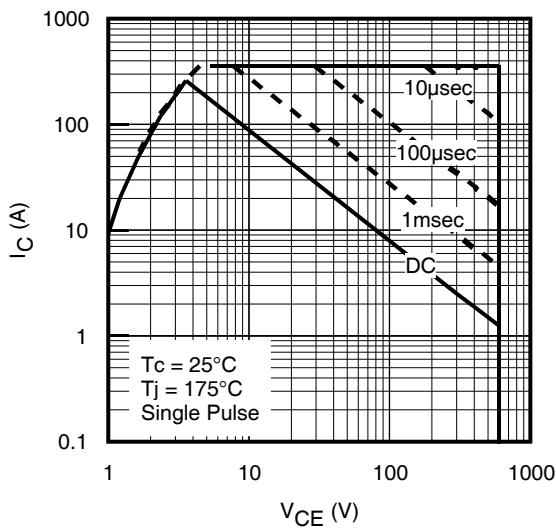


Fig. 3 - Forward SOA
 $T_C = 25^\circ\text{C}$, $T_J \leq 175^\circ\text{C}$; $V_{GE} = 15\text{V}$

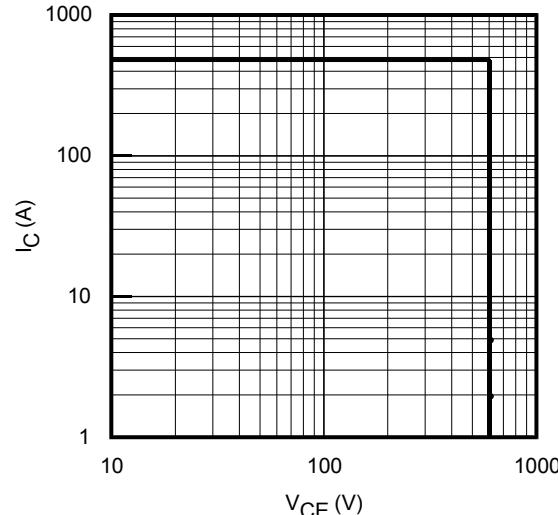


Fig. 4 - Reverse Bias SOA
 $T_J = 175^\circ\text{C}$; $V_{GE} = 20\text{V}$

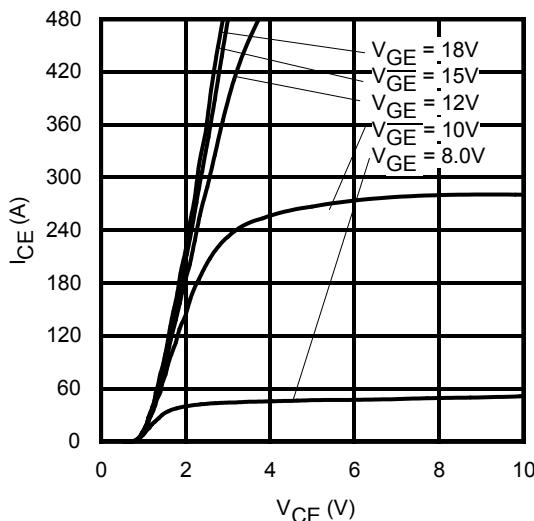


Fig. 5 - Typ. IGBT Output Characteristics
 $T_J = -40^\circ\text{C}$; $t_p = 20\mu\text{s}$

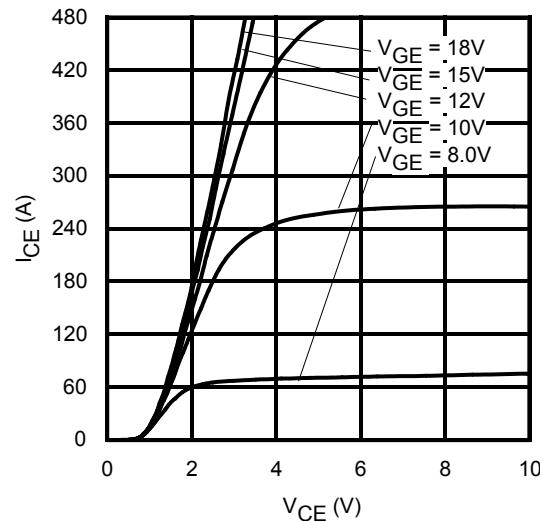


Fig. 6 - Typ. IGBT Output Characteristics
 $T_J = 25^\circ\text{C}$; $t_p = 20\mu\text{s}$

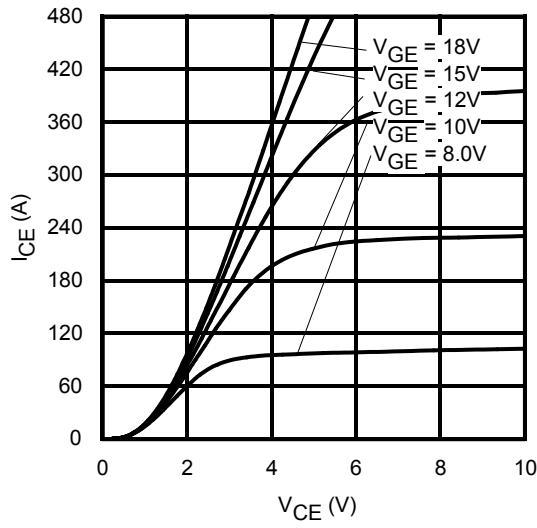


Fig. 7 - Typ. IGBT Output Characteristics
 $T_J = 175^\circ\text{C}$; $t_p = 20\mu\text{s}$

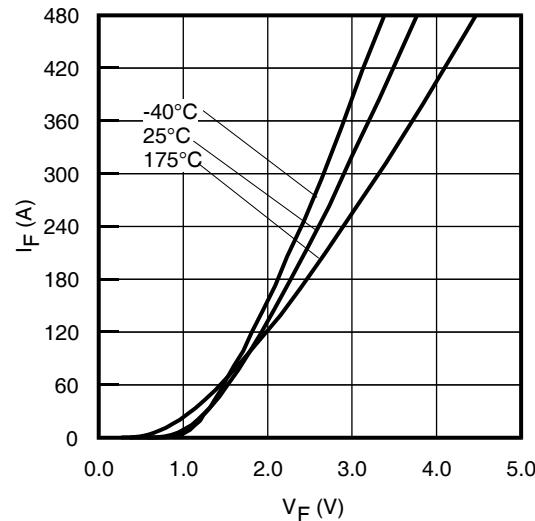


Fig. 8 - Typ. Diode Forward Characteristics
 $t_p = 20\mu\text{s}$

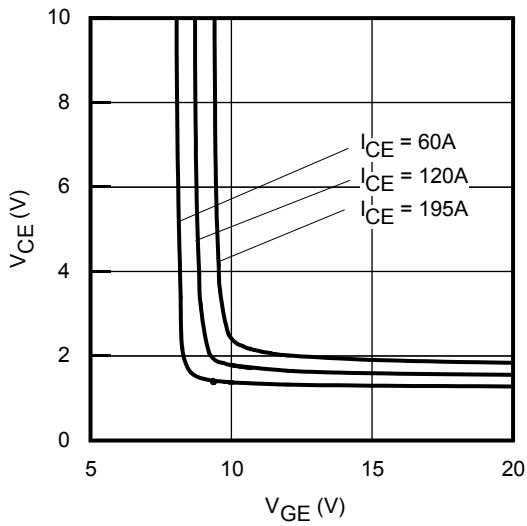


Fig. 9 - Typical V_{CE} vs. V_{GE}
 $T_J = -40^\circ\text{C}$

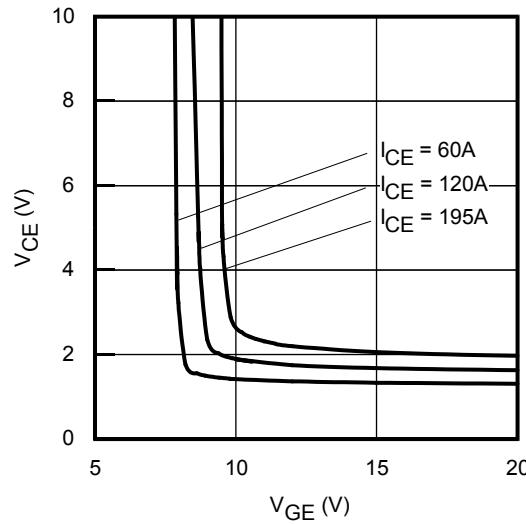


Fig. 10 - Typical V_{CE} vs. V_{GE}
 $T_J = 25^\circ\text{C}$

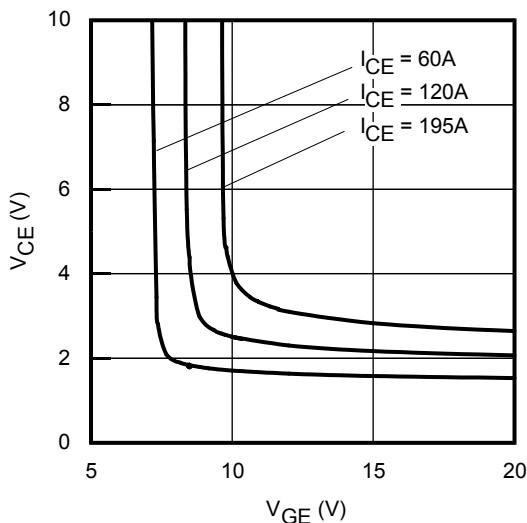


Fig. 11 - Typical V_{CE} vs. V_{GE}
 $T_J = 175^\circ\text{C}$

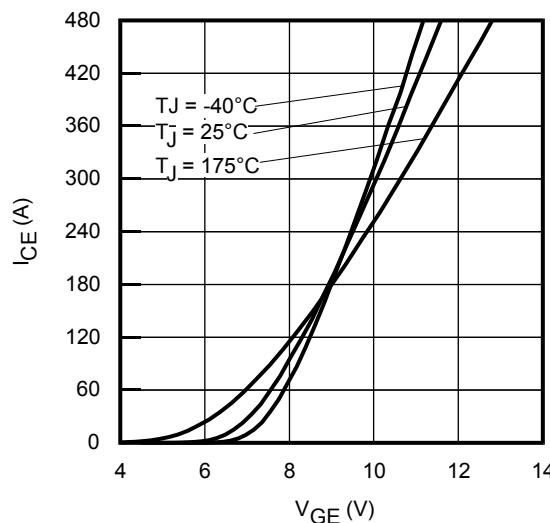
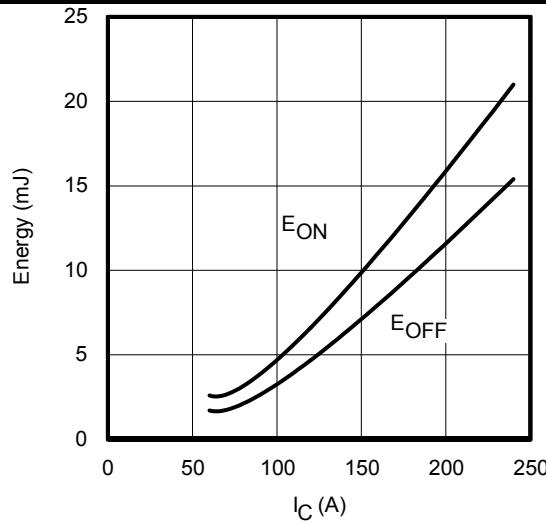
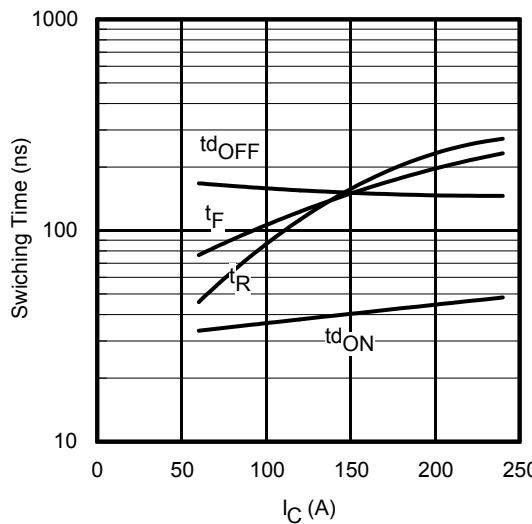
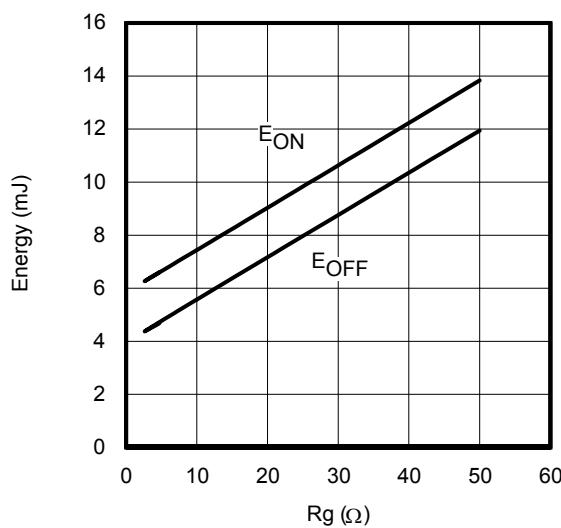
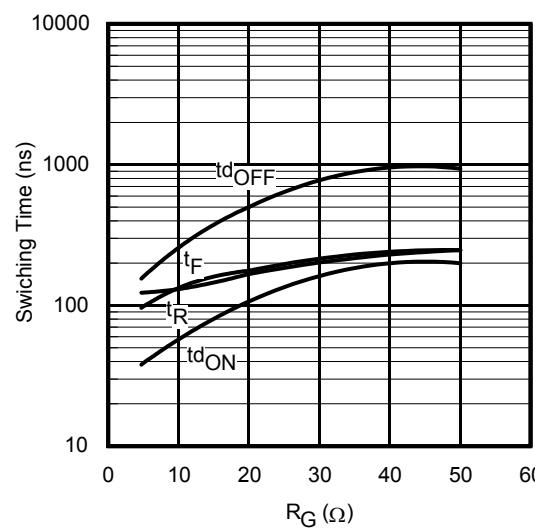
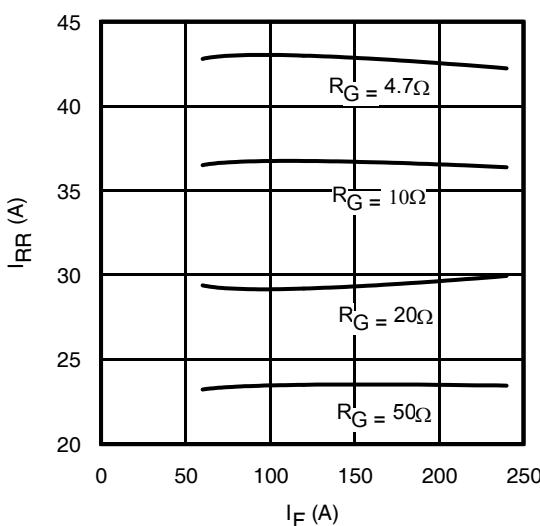
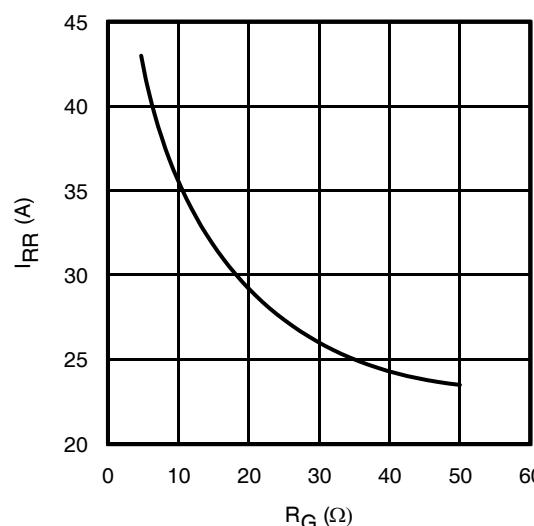


Fig. 12 - Typ. Transfer Characteristics
 $V_{CE} = 50\text{V}$; $t_p = 20\mu\text{s}$


Fig. 13 - Typ. Energy Loss vs. I_C
 $T_J = 175^\circ C; L = 0.087\text{mH}; V_{CE} = 400V, R_G = 4.7\Omega; V_{GE} = 15V$

Fig. 14 - Typ. Switching Loss vs. I_C
 $T_J = 175^\circ C; L = 0.087\text{mH}; V_{CE} = 400V, R_G = 4.7\Omega; V_{GE} = 15V$

Fig. 15 - Typ. Energy Loss vs. R_G
 $T_J = 175^\circ C; L = 0.087\text{mH}; V_{CE} = 400V, I_{CE} = 120A; V_{GE} = 15V$

Fig. 16 - Typ. Switching Time vs. R_G
 $T_J = 175^\circ C; L = 0.087\text{mH}; V_{CE} = 400V, I_{CE} = 120A; V_{GE} = 15V$

Fig. 17 - Typ. Diode I_{RR} vs. I_f
 $T_J = 175^\circ C$

Fig. 18 - Typ. Diode I_{RR} vs. R_G
 $T_J = 175^\circ C$

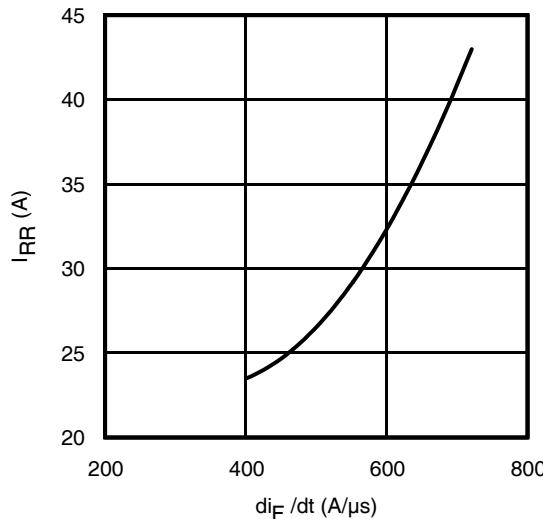


Fig. 19 - Typ. Diode I_{RR} vs. diF/dt
 $V_{CC} = 400V$; $V_{GE} = 15V$; $I_F = 120A$; $T_J = 175^{\circ}C$

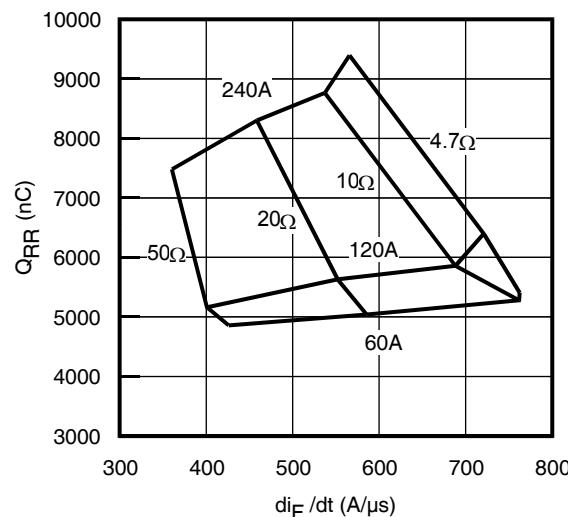


Fig. 20 - Typ. Diode Q_{RR} vs. diF/dt
 $V_{CC} = 400V$; $V_{GE} = 15V$; $T_J = 175^{\circ}C$

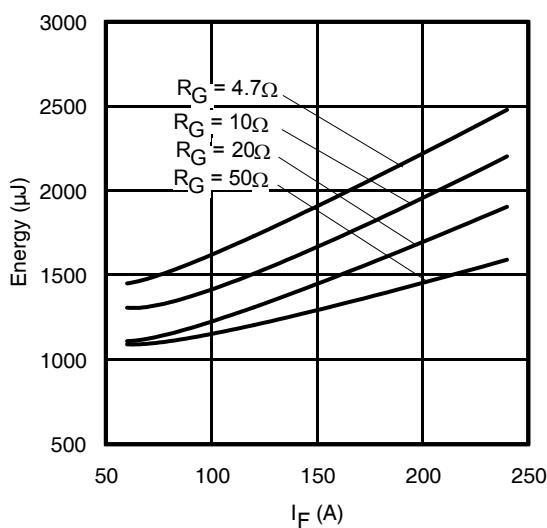


Fig. 21 - Typ. Diode E_{RR} vs. I_F
 $T_J = 175^{\circ}C$

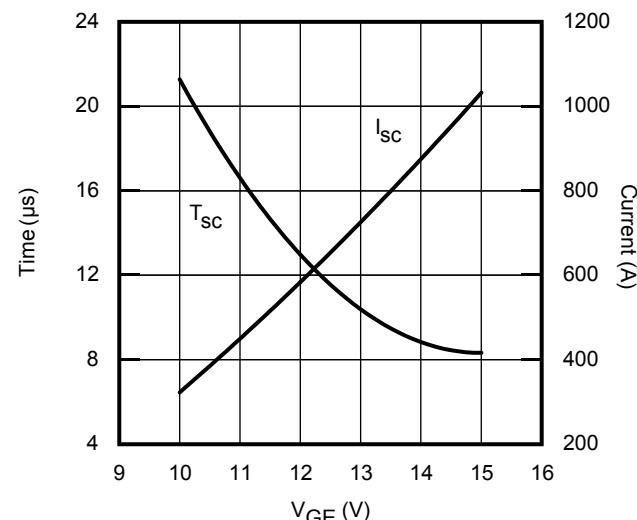


Fig. 22 - V_{GE} vs. Short Circuit Time
 $V_{CC} = 400V$; $T_C = 25^{\circ}C$

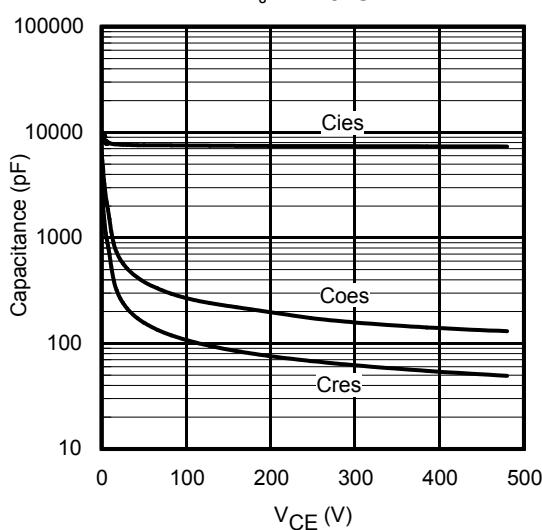


Fig. 23 - Typ. Capacitance vs. V_{CE}
 $V_{GE} = 0V$; $f = 1MHz$

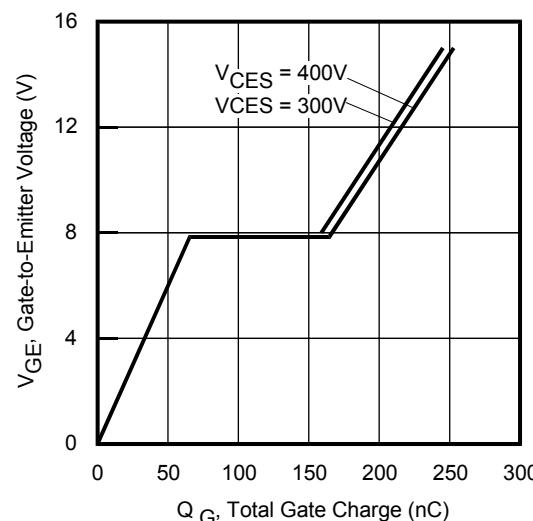


Fig. 24 - Typical Gate Charge vs. V_{GE}
 $I_{CE} = 120A$

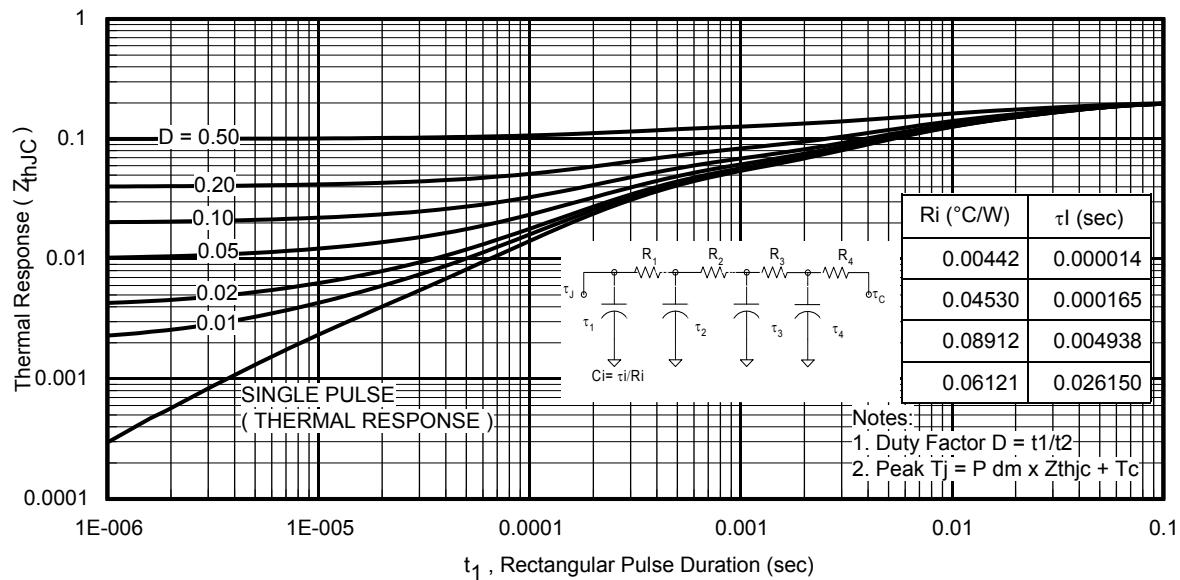


Fig 25. Maximum Transient Thermal Impedance, Junction-to-Case (IGBT)

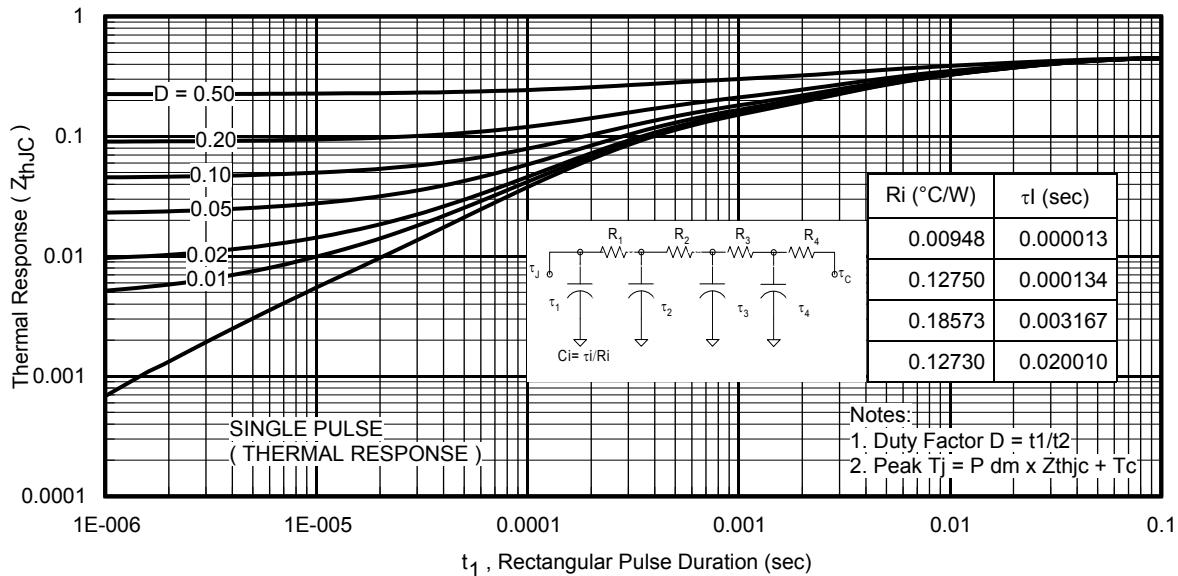
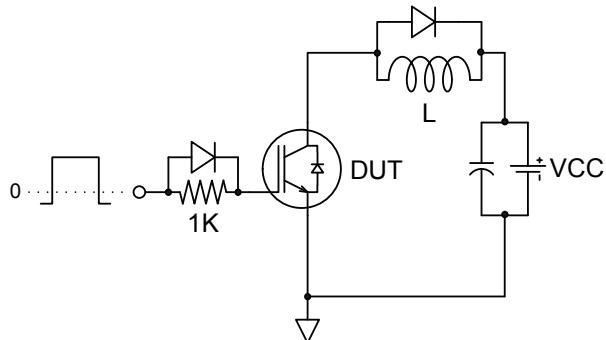
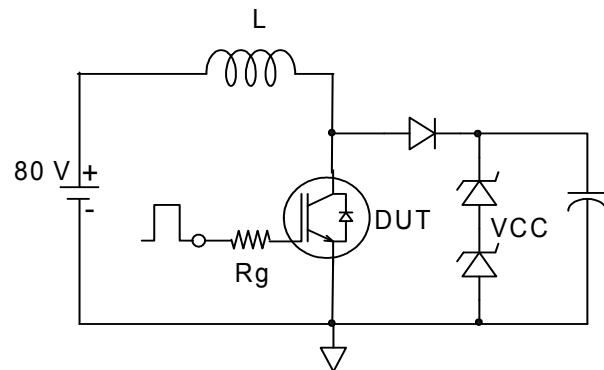


Fig 26. Maximum Transient Thermal Impedance, Junction-to-Case (DIODE)



Gate Charge Circuit



RBSOA Circuit

Fig.C.T.1 - Gate Charge Circuit (turn-off)

Fig.C.T.2 - RBSOA Circuit

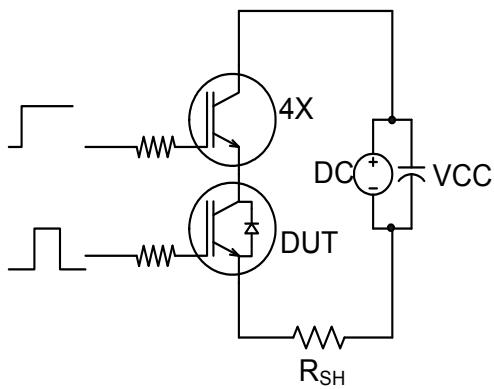


Fig.C.T.3 - S.C. SOA Circuit

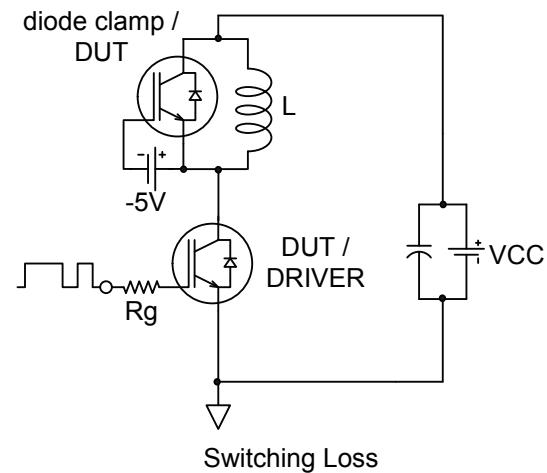


Fig.C.T.4 - Switching Loss Circuit

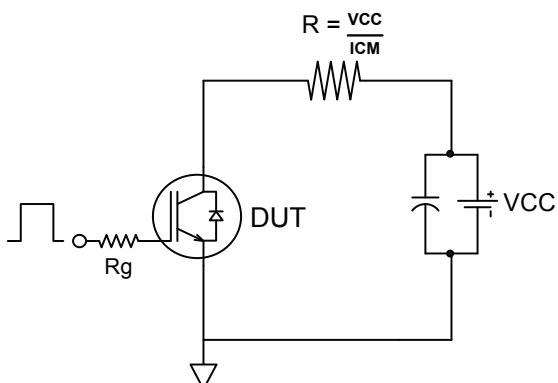


Fig.C.T.5 - Resistive Load Circuit

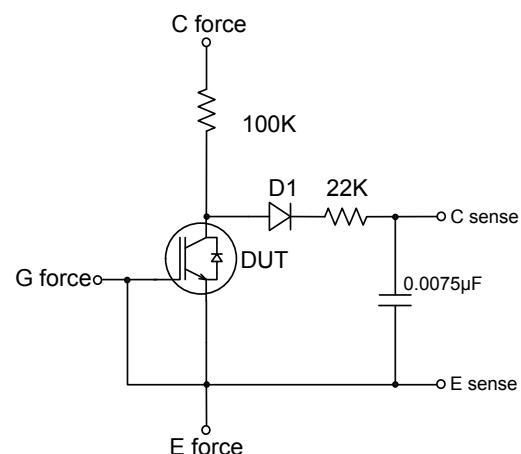


Fig.C.T.6 - BVCES Filter Circuit

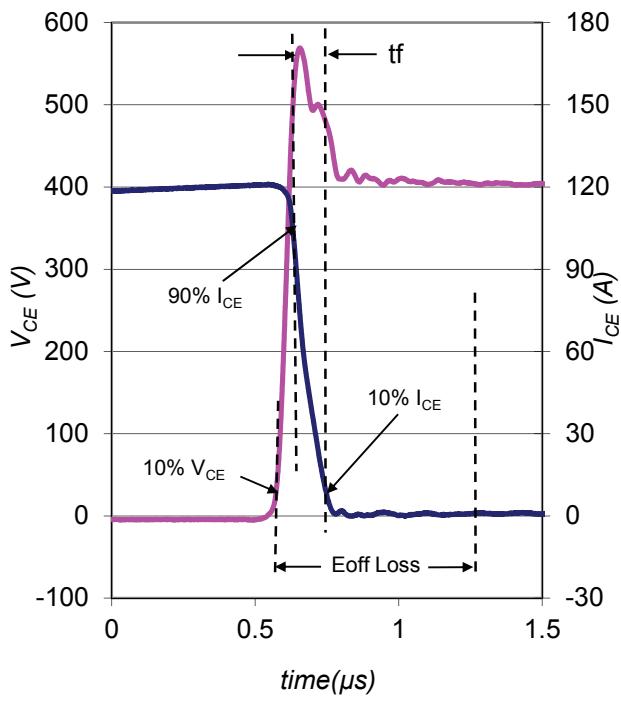


Fig. WF1 - Typ. Turn-off Loss Waveform
@ $T_J = 175^\circ\text{C}$ using Fig. CT.4

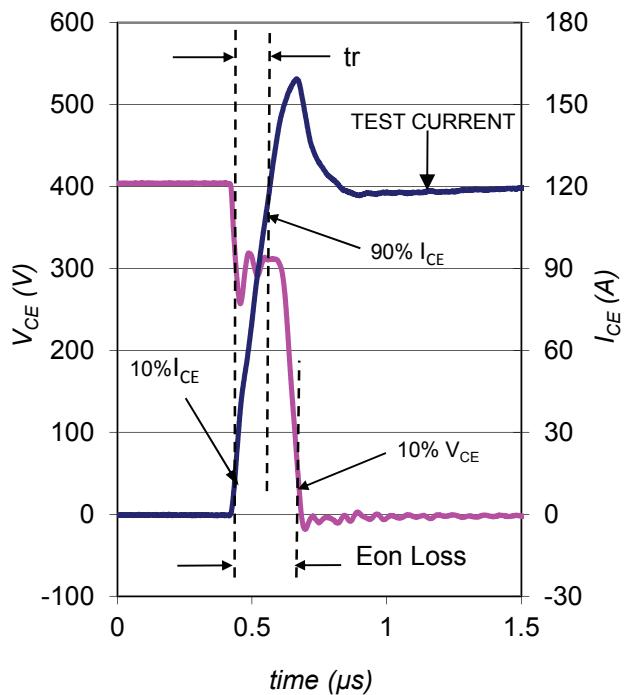


Fig. WF2 - Typ. Turn-on Loss Waveform
@ $T_J = 175^\circ\text{C}$ using Fig. CT.4

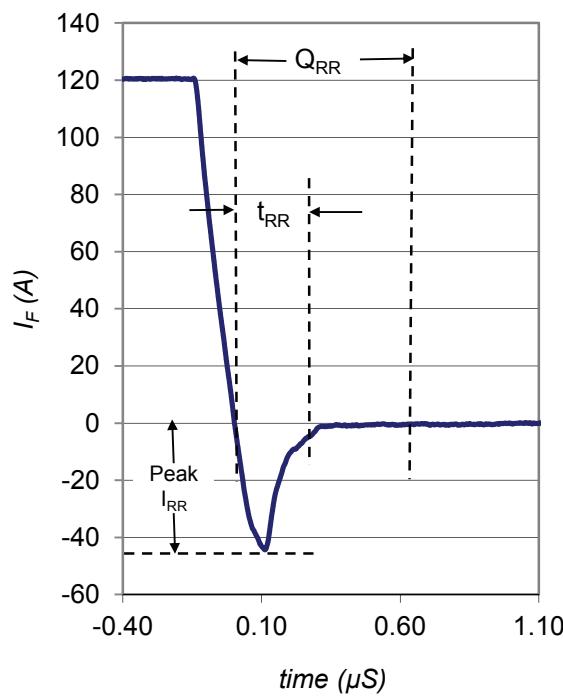


Fig. WF3 - Typ. Diode Recovery Waveform
@ $T_J = 175^\circ\text{C}$ using Fig. CT.4

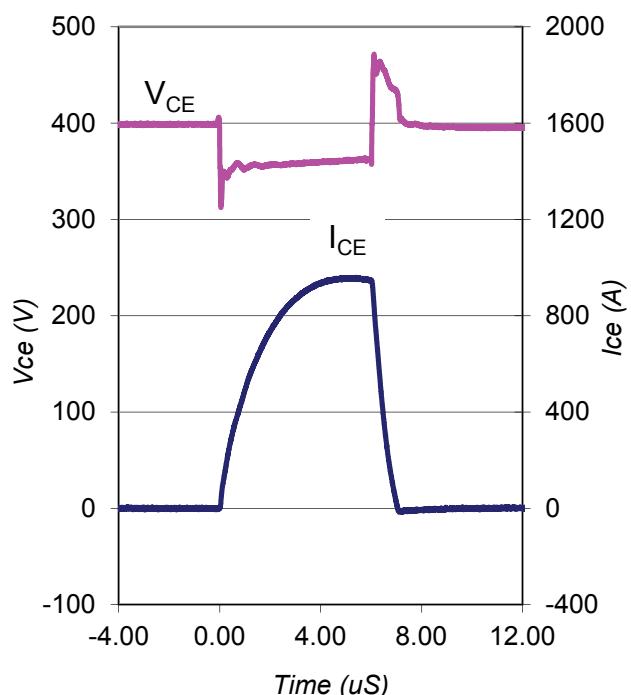
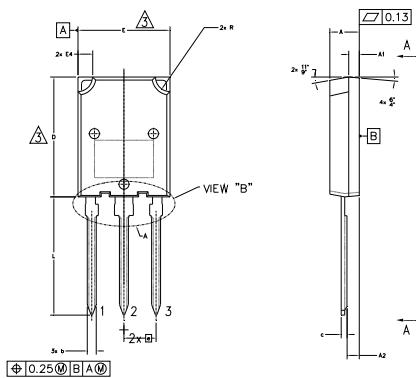


Fig. WF4 - Typ. S.C. Waveform
@ $T_J = 25^\circ\text{C}$ using Fig. CT.3

Case Outline and Dimensions-PG-T0274-3-903 (Dimensions are shown in millimeters (inches))



NOTES:

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994

2. DIMENSIONS b1, b3, b5, c1 & c3 APPLY TO BASE METAL ONLY.

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER EXTREMES OF THE PLASTIC BODY.

4. ALL DIMENSIONS SHOWN IN MILLIMETERS.

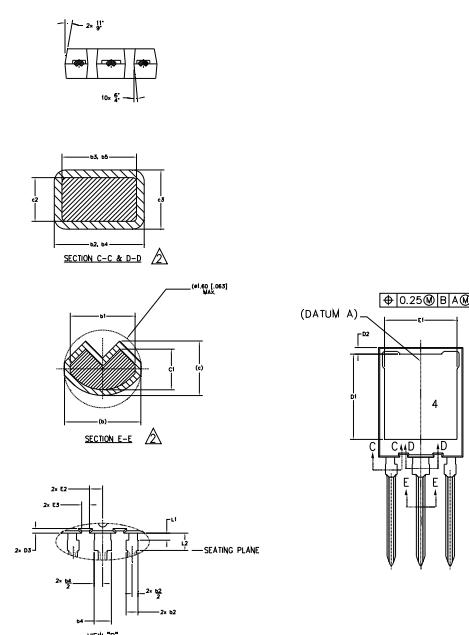
5. CONTROLLING DIMENSION: MILLIMETER.

6. OUTLINE CONFORMS TO JEDEC OUTLINE TO-274AA

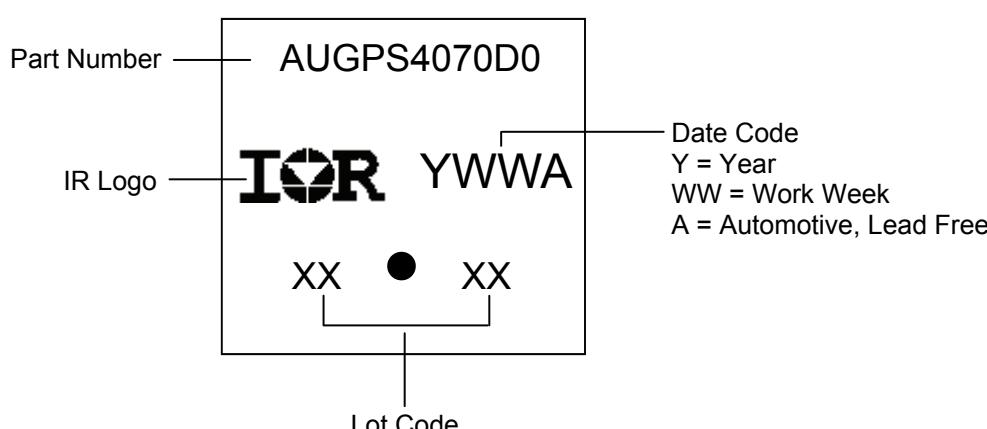
| SYMBOL | DIMENSIONS | | | | NOTES | |
|--------|-------------|-------|--------|------|-------|--|
| | MILLIMETERS | | INCHES | | | |
| | MIN. | MAX. | MIN. | MAX. | | |
| A | 4.90 | 5.10 | .193 | .201 | | |
| A1 | 1.70 | 2.10 | .067 | .083 | | |
| A2 | 1.88 | 2.13 | .074 | .084 | | |
| b | 1.25 | 1.55 | .049 | .061 | | |
| b1 | 1.20 | 1.50 | .047 | .059 | 2 | |
| b2 | 2.00 | 2.30 | .079 | .091 | | |
| b3 | 1.92 | 2.22 | .076 | .087 | 2 | |
| b4 | 2.96 | 3.52 | .116 | .139 | | |
| b5 | 2.90 | 3.46 | .114 | .136 | 2 | |
| c | 0.86 | 1.16 | .034 | .046 | | |
| c1 | 0.80 | 1.10 | .031 | .043 | 2 | |
| c2 | 0.65 | 0.85 | .026 | .033 | | |
| c3 | 0.50 | 0.70 | .020 | .028 | 2 | |
| D | 20.16 | 20.44 | .794 | .805 | 3 | |
| D1 | 15.50 | 15.80 | .610 | .622 | | |
| D2 | 0.87 | 1.17 | .034 | .046 | | |
| D3 | 0.80 | 1.26 | .031 | .050 | | |
| E | 15.20 | 15.80 | .598 | .622 | | |
| E1 | 13.40 | 13.80 | .528 | .543 | | |
| E2 | 1.42 | 3.23 | .056 | .127 | | |
| E3 | 1.20 | 1.60 | .047 | .063 | | |
| E4 | 2.00 | 3.00 | .079 | .118 | | |
| e | 5.45 | BSC | .215 | BSC | | |
| L | 19.72 | 20.38 | .776 | .802 | | |
| L1 | 1.10 | 1.50 | .043 | .059 | | |
| L2 | 2.85 | 3.61 | .112 | .142 | | |
| R | 2.00 | 3.00 | .079 | .118 | | |

LEAD ASSIGNMENTS

| MOSFET | IGBT |
|-----------|--------------|
| 1. GATE | 1. GATE |
| 2. DRAIN | 2. COLLECTOR |
| 3. SOURCE | 3. Emitter |
| 4. DRAIN | 4. COLLECTOR |



PG-T0274-3-903 -Part Marking Information



Qualification Information

| | | | |
|-----------------------------------|----------------------|---|-----|
| | | Automotive (per AEC-Q101) | |
| Qualification Level | | This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. | |
| Moisture Sensitivity Level | | PG-T0274-3-903 | N/A |
| ESD | Human Body Model | Class H3B(+/- 8000) [†] AEC-Q101-001 | |
| | Charged Device Model | Class C3 (+/- 2000) [†] AEC-Q101-005 | |
| RoHS Compliant | | Yes | |

† Highest passing voltage.

Revision History

| Revision | Date | Subjects (major changes since last revision) |
|----------|------------|--|
| 2.0 | 12/12/2016 | • Final Datasheet. |
| 2.1 | 08/31/2017 | • Corrected typo error on part marking. |
| 2.2 | 11/14/2017 | • Updated with IFX nomenclature. |
| 2.3 | 07/19/2018 | • Updated with minor changes. |
| 2.4 | 12/03/2018 | • Updated with package outline. |

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